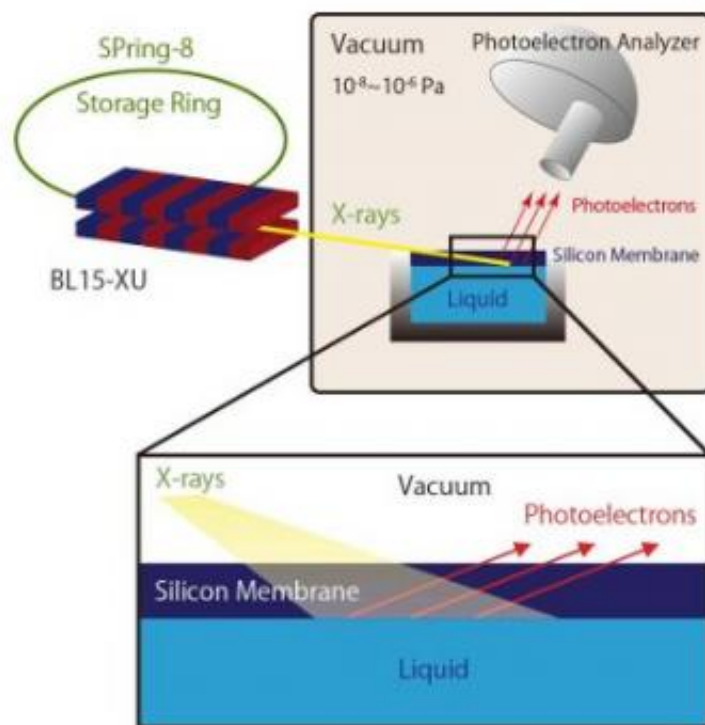


In situ tracking of electrochemical reactions at solid / liquid interfaces by photoelectron spectroscopy

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Layout of the In Situ XPS Measurement System

A research group led by NIMS GREEN and JST, in collaboration with WPI-MANA and the Synchrotron X-ray Station at SPring-8, developed a new measurement system using high-energy X-rays of SPring-8 and a Si thin-membrane window. Through this achievement, the group

succeeded for the first time in the world in tracking electrochemical reactions at solid/liquid interfaces in situ by X-ray photoelectron spectroscopy, which could only be used for measurement in a vacuum in the past.

A research group led by Prof. Dr. Kohei Uosaki, Research Manager of the Batteries and Fuel Cells Field at the Global Research Center for Environment and Energy based on Nanomaterials Science (GREEN) of the National Institute for Materials Science (NIMS) and Dr. Takuya Masuda, Researcher of the Precursory Research for Embryonic Science and Technology (PRESTO) program at the Japan Science and Technology Agency (JST), in collaboration with NIMS International Center for Materials Nanoarchitectonics (WPI-MANA) and the Synchrotron X-ray Station at SPring-8, developed a new measurement system using high-energy X-rays of SPring-8 and a silicon (Si) thin-membrane window. Through this achievement, the group succeeded for the first time in the world in tracking electrochemical reactions at solid/liquid interfaces in situ by X-ray photoelectron spectroscopy (XPS), which could only be used for measurement in a vacuum in the past.

A solid/liquid interface is an important part that converts and uses energy in familiar energy devices, such as fuel cells and solar cells. Recent research and development which aims to maximize the efficiency of energy use faces the need to break away from materials development dependent on empirical rules and to adopt clear evaluation methods that enable strategic materials design. Accordingly, there has been a strong desire for methods to directly observe and measure the dynamic behavior of reactions at solid/liquid interfaces in the environment where the reactions are taking place (in situ). Meanwhile, XPS is a method to investigate the surface species and oxidation states of the surface of a substance by irradiating the substance with X-rays and analyzing the energy of the photoelectrons emitted from the

elements on the surface. Conventionally, XPS could only be used for measurement in a vacuum, and could not be used to directly observe the reactions at solid/liquid interfaces in situ.

The research group succeeded in observing the electrochemical reactions at a solid/liquid interface in a non-vacuum environment in situ by having high-energy synchrotron X-rays of SPring-8 penetrate through a thin Si membrane window with a thickness of 15 nm. Specifically, the group developed a measurement system that uses a thin Si membrane as a window for transmitting X-rays and photoelectrons, as a barrier separating a vacuum and a liquid, and as an electrode for [electrochemical reactions](#), and uses the high-energy synchrotron X-rays of SPring-8 to detect, on the vacuum side (through the thin membrane), the photoelectrons that have been emitted at the interface between the thin Si membrane window (solid) and the liquid. With this system, the group succeeded in in situ observation of potential-induced Si oxide growth in water.

The research results are expected to further elucidate the process at solid/liquid interfaces of major energy devices such as rechargeable batteries and fuel cells. At the same time, they are expected to contribute to the development and better performance of important parts such as cell electrodes and catalyst materials as a result of clarifying the reaction mechanism and problems in existing materials. In particular, quantitative investigation of the composition and oxidation states of interfaces, which was difficult in the past, becomes possible, which helps illuminate the deterioration mechanism of electrodes and electrolytes through identification of side reactions and the products of the reactions. Also, since XPS has been used for materials design and development in diverse fields including the industrial field and the medical field, the research results are expected to contribute to elucidating the mechanism of a broad range of phenomena in which interface reactions play an important role in those fields.

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